Applicant(s)/Patent Under Application/Control No. Reexamination 09/994,774 HEINRICH ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Katarzyna Wyrozebski Lee 1714 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,250,630 10-1993 Α Oshima et al. 525/301 US-В С US-D US-Е US-F US-G US-US-Η US-US-J Κ US-L US-M US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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